

BETTER BY DESIGN

The greatest results always begin with a good design. In the world of test and burn-in, the variations are endless. That's why this session features a broad assortment of design topics and perspectives. Beyond socket design, we'll learn about designing the right handler for the job. Next is a birds-eye view of a socket's creation from design concept to final assembly, followed by a specific look at designs and applications for package-on-package (PoP) device testing.



A Novel Nested Doll Concept in Universal Kit for Test Handler

Yee Wei Tiang—Intel (Malaysia)

Anatomy of a Socket

Paul F. Ruo-Aries Electronics, Inc.

Special Designs and Applications for PoP Device Testing

Siang Soh, Frank Zhou, Jon Diller, James Spooner, Khaled Elmadbouly —Interconnect Devices, Inc.

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A Novel Nested Doll Concept in Universal Kit for Test Handler

TIANG YEE WEI INTEL ATM PENANG, MALAYSIA



2013 BiTS Workshop March 3 - 6, 2013



Universal Kit For Test Handler Agenda

- Background
- Understand the RFS handler kit & its challenges
- The Solution
 - Theory of the invention
 - Application
- Universal kits for others handler
- Conclusion

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Background

What is the challenge today in Test operation in semiconductor industry?

- Continuous to improve productivity
- Drive cost savings in Test Operation
- Increase of product mix and lower volume
- Test Operation <u>flexibility</u> and <u>machine</u> <u>utilization</u>

A Novel Nested Doll Concept in Universal Kit for Test Handler

Conventional way of test handler kits

- Cater only single package form factors
- Average 6 hours per kit conversion
- Average 8 conversions per day concurrently across Test area depending on product mix
- Support 3 different types of test handlers

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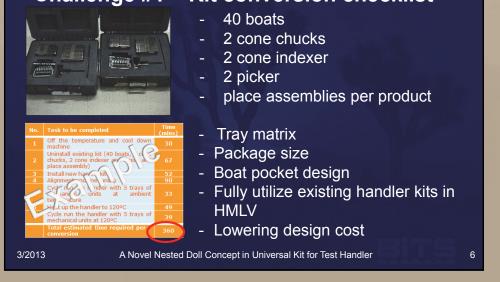
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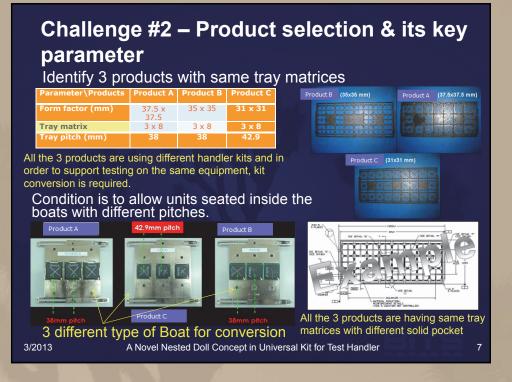
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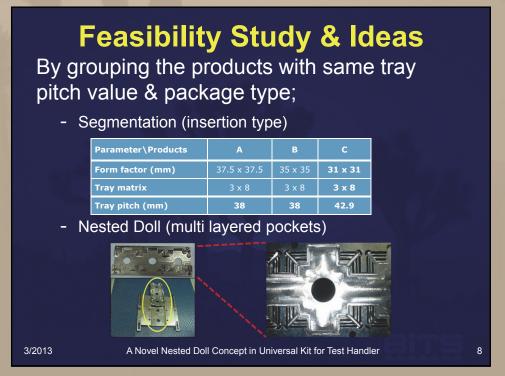
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Understand the RFS handler kit & its challenges Challenge #1 – Kit conversion checklist









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The Solution

1) The Theory of Inventive Problem Solving (TRIZ)

- Segmentation (Enables objects to be divided into independent parts)

- Nested Doll (Enables multiple objects to be placed inside others)

2) Pick and Place assembly / nest design

- It carries plug and play concept to handle different tray pitch and package dimension

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Demonstration

- Insert type and multi layer boat design
- Redesign multi layered pocket. (smallest package seated at lowest layer, largest package seated at highest layer)



• Reused and segmented the universal boat.





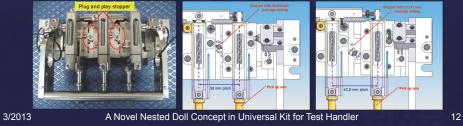
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- Plug and play input pick and place assembly
- Conventional pick and place assembly with fixed pitch value per tray pitch.



• New design pick and place with flexible pitch value per tray pitch.

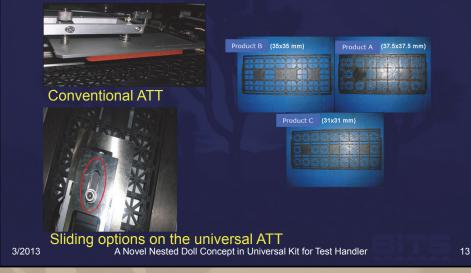




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Sliding type design for auto tray transfer (ATT)

• Redesign ATT into adjustable mode.



- Plug and Play nest design

- Universal static dissipative Nest or work press fit is being used on the cone chuck to hold the units during test.
- Cone chuck guide hole located on both sides of the outer multi layer pocket will determine which package size should fit.
- Only swap the Nest without having to remove the cone chuck.



Cone chuck guide hole on Nest

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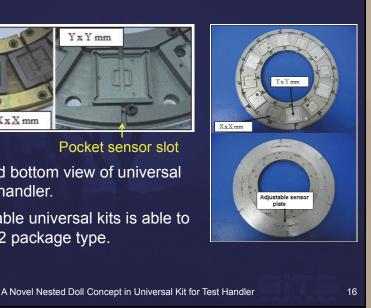
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Universal kits for others handler



Pocket sensor slot

- Front and bottom view of universal tunable handler.
- This tunable universal kits is able to support 2 package type.



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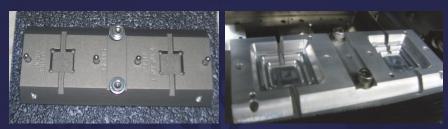
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Universal kits for others handler



Conventional shuttle vs Universal shuttle for another type of handler

Guess how many package able to support for this universal shuttle?

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Conclusion

Universal kit is a good example of how engineering design changes can dramatically improve manufacturing productivity:

- -Conversion time
- -Reuse conventional parts
- -Cost saving
- -Low maintenance
- -Flexibility

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